

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10567481	SHEN ET AL.
	Examiner	Art Unit
	M. Lee	2622

SEARCHED

Class	Subclass	Date	Examiner
348	725, 552-558, 705, 706	3/2/09	ml

SEARCH NOTES

Search Notes	Date	Examiner
east	3/2/09	ml

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

	/M. Lee/ Primary Examiner.Alt Unit 2622
--	--